Detector Design and Analysis Technique for Local Electric Field Fluctuation Diagnostic Using Spatial Heterodyne Spectroscopy

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APS DPP, Portland November 9, 2018



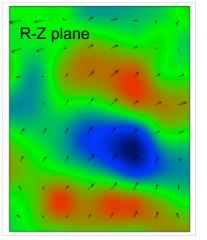
Introduction



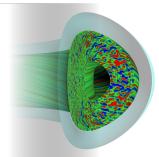


Understanding Turbulence in Tokamaks is a Fundamental Challenge for Fusion Energy

- Plasma turbulence in tokamaks results in anomalous transport
 - Cross-field transport >> neoclassical predictions
- Present plasma diagnostics measure key fluctuating parameters \tilde{n} , \tilde{T}_i , \tilde{T}_e , \tilde{v}
- Measurement of electrostatic field turbulence $(\tilde{E} \sim k_{\perp} \tilde{\phi})$ remains a challenge, gives \tilde{v}
 - $\tilde{E}_{\theta} \times B_{\phi} \cong \tilde{v}_r$: turbulent cross-field transport, $\tilde{E}_r \times B_{\phi} \cong \tilde{v}_{\theta}$: shear-flow and zonal flow dynamics
- Local magnetic field fluctuation (\tilde{B}) measurement also challenging, could provide critical information
 - 3D magnetic field perturbation penetration into plasma pedestal



Density perturbations and calculated velocimetry in DIII-D plasma



GYRO turbulence simulation



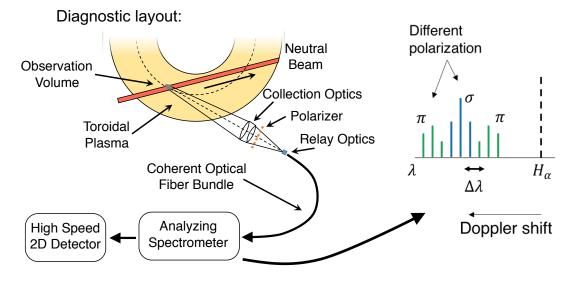
Motional Stark Effect Field Used as Carrier Signal for \tilde{E}

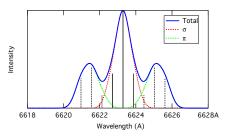
 Local plasma fluctuations → Stark multiplet fluctuations

$$\mathbf{E}_{t} = \mathbf{v}_{b} \times \mathbf{B} + \mathbf{E}_{p} + \mathbf{v}_{b} \times \widetilde{\mathbf{B}} + \widetilde{\mathbf{E}}_{p}$$

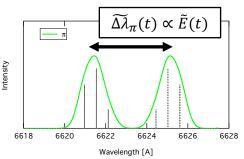
$$\widetilde{\Delta}_{Stark} \propto \widetilde{\mathbf{E}}_{t}$$

- Measure high-speed variations in π/σ line intensity ratio or in π -components line separation to derive \tilde{E} or \tilde{B}
- Spatial Heterodyne Spectrometer (SHS) provides high throughput analyzer of multiplet spectrum
- New CMOS imaging system provide detection and DAQ





Model Ha Stark Spectrum: 80 keV, 0.5 T

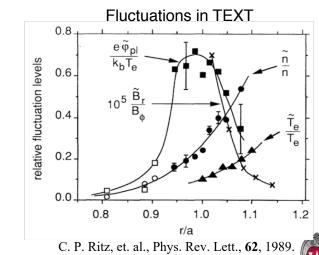




$|\vec{E}/\vec{E}_{MSE}|$ in Fusion Grade Plasmas ~10⁻³

Experiment	T _{e,0} (keV)	B (T)	a (m)	\widetilde{E}/E_{MSE}
NSTX-U	~2-4	1	0.6	$1 - 2 \times 10^{-3}$
DIII-D	2-5	2	0.7	$0.5 - 1 \times 10^{-3}$
Pegasus	~0.3	0.3	0.35	$0.7 - 1 \times 10^{-3}$

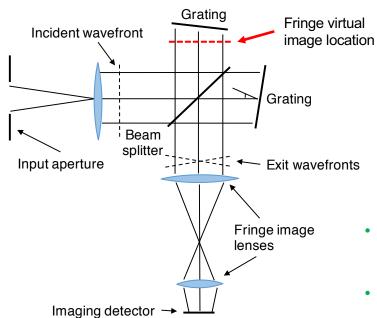
- Tokamak drift wave turbulence scaling gives $\tilde{E} \propto T_e/a$
- \tilde{E} turbulence broadband, majority of fluctuation power < 300 kHz
- \tilde{E} , \tilde{n} rise from core to edge
- \tilde{E}/E_{MSE} at or bellow photon noise floor for BES (typical rms noise ~1%)
 - Two independent but spatially correlated measurements (e.g. $\langle \tilde{E}\tilde{n} \rangle$) made simultaneously can suppress incoherent photon noise another ~10x

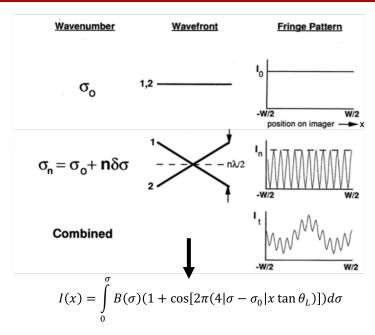




Spatial Heterodyne Spectroscopy Technique Utilized for $\Delta \tilde{\lambda}_{\pi}(t)$ Measurement

- Self scanned, 2 beam interferometer
- Input wavelengths heterodyned around Littrow wavelength





- Interferometer class spectral resolution and throughput without moving parts
- $R \sim 10^4$ and U = 0.016 cm²sr can be readily obtained with relatively small optics compared to slit systems





Spectrometer Design Points for Field Test at DIII-D

- SHS prototype ("Phase I") designed, built, and evaluated at UW-Madison
 - System design for flexibility, built with "stock" optics
- Field tests at DIII-D:
 - Photon flux adequate for ~1% photon statistics turbulence measurement
 - Evaluation of vibrational environment → requires multilevel isolation strategy for next stage SHS
 - Experience with SHS data analysis
- Next stage SHS for turbulence measurement being built
 - ~500 kHz detector system
 - Fast, robust, analysis algorithm for $\tilde{\mathbf{E}}$ extraction

$\tilde{\mathbf{E}}$ diagnostic system parameters:

Parameter	Units	Value
Design spectral resolution @ 656 nm	nm (cm ⁻¹)	0.086(2)
Max throughput	mm² sr	4.8
Grating width	cm	7.62
Grating groove density	mm ⁻¹	50
Sampling speed	kHz	430-700
Image size	mm	2x2
f/# at detector		1
D_lpha filter transmission	%	>95
D_lpha filter 90-10% cutoff & uniformity	nm	0.2
Fringe imaging system magnification		0.033

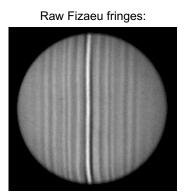


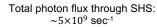


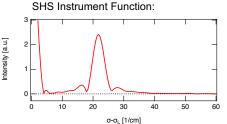
First Plasma Light Through Prototype SHS

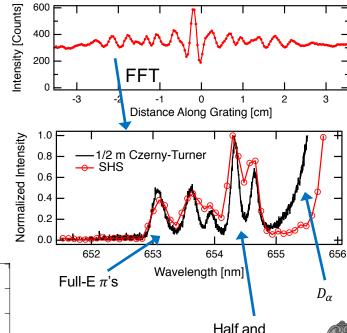
- Several interferometer components tested at D3D before LTO3
- Prototype SHS and survey spectrometer (1/2 m Princeton Instruments, 100 μm slit) beam emission spectrums are comparable
 - Input: Two radially adjacent channels from BES fiber array
 - Linear polarizer removes σ components
- $R \cdot U \equiv \frac{\lambda}{\delta \lambda} \cdot \frac{\pi A_s}{4(f/\#)^2}$ product:
 - $1/2 \text{ m Czerny-Turner } (\delta \lambda = 0.05 \text{ nm}) = 0.73$
 - SHS $(\delta \lambda = 0.13 \text{ nm}) = 128$

SHS output produced by tokamak light with linear polarizer installed at machine:







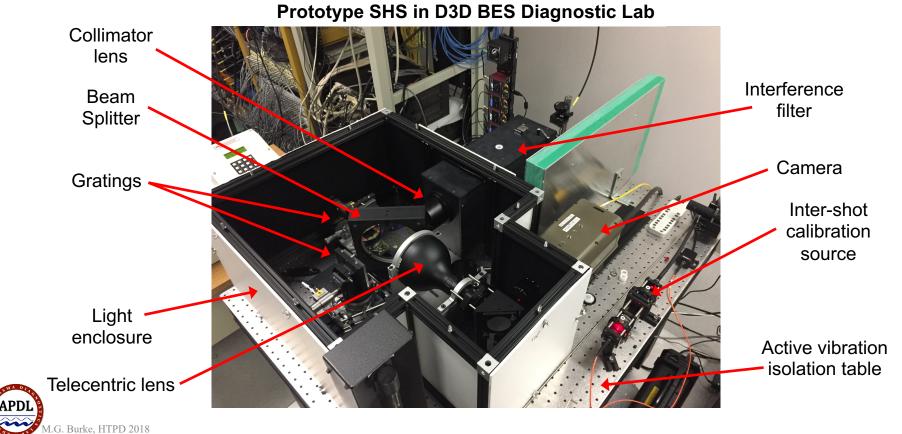


Burke M.G., et al., Rev. Sci. Inst., (2018)

third-E π 's

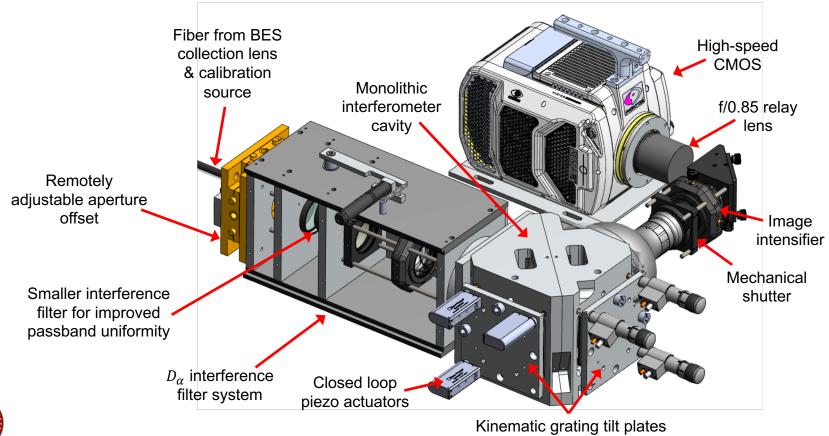


Phase I deployed to D3D for Evaluation in Tokamak Environment



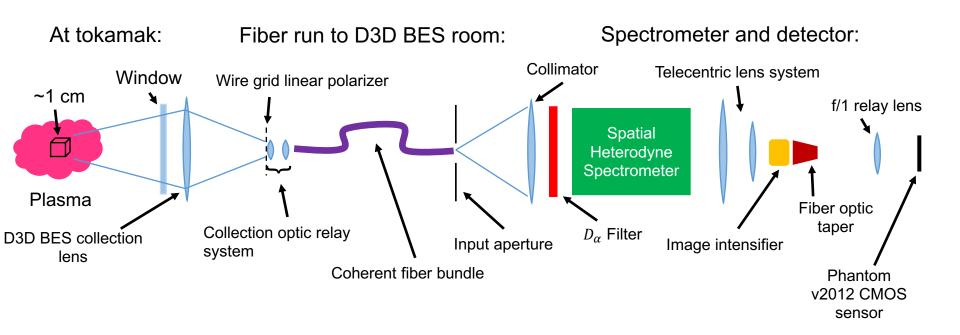


Design Modification and Upgrades for Next Stage SHS





Diagnostic Layout







\tilde{E} Extraction Algorithm





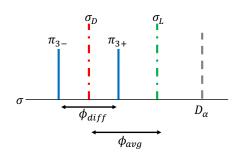
\tilde{E} Extraction with Weighted Linear Least Squares Algorithm

- **Motivation:** need fast & robust algorithm with good noise performance to extract $\tilde{E}(t)$ from ~20 gigabyte/shot photon noise limited dataset
- Stark SHS interferogram nonlinear function, but highly symmetric \rightarrow linearize \rightarrow best-fit $\tilde{\mathbf{E}}$ extracted from interferogram via multiple linear regression analysis method (least-squares fit)

$$I(\sigma, x) = \int S(\sigma) \left(1 + \cos\left[8\pi x \tan\theta_L\left((\sigma_{D0} \pm \Delta\sigma(\mathbf{E_t})) - \sigma_L\right)\right] d\sigma$$

$$I_{\pi}(x) = S_0 \sum_{n=2}^{4} a_n \left(2 + 2e^{-\pi(4x \tan\theta_L w)^2} \cos(\phi_{avg}) \cos(\phi_{diff})\right)$$

$$\phi_{avg} = 8\pi x \tan\theta_L \left(\sigma_{D0} - \sigma_L\right), \qquad \phi_{diff} = 8\pi x \tan\theta_L n\delta(|\mathbf{E_{MSE}}| + |\mathbf{E_p} + \tilde{\mathbf{E}}|)$$



- $ilde{\mathbf{E}}$ results in very small changes in $\operatorname{\underline{only}} \phi_{diff}$
- Linearized interferogram: full-energy only, six π -components with peak broadening:

$$I(x) = S_0 \Big[2(a_2 + a_3 + a_4) + 2e^{-\pi(4x \tan \theta_L w)^2} a_n \cos(Ax(\sigma_{D0} - \sigma_L)) (\cos(Axn\delta |\mathbf{E_{MSE}}|) + \cdots) \Big]$$

$$- \Big| \widetilde{\mathbf{E}} + \mathbf{E_p} \Big| S_0 \delta \Big[2e^{-\pi(4x \tan \theta_L w)^2} A a_n x n \cos(Ax(\sigma_{D0} - \sigma_L)) (\sin(Axn\delta |\mathbf{E_{MSE}}|) + \cdots) \Big]$$



Linear in coefficients $S_0 = c_1$ and $|\tilde{\mathbf{E}} + \mathbf{E}_p| S_0 \delta = c_2 \rightarrow \text{interferogram in form } y(x_i) = \sum_{k=1}^m c_k f_k(x_i)$

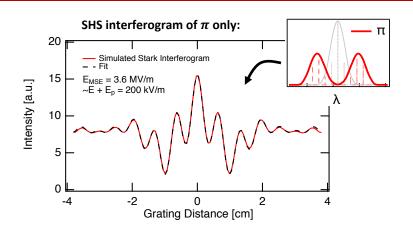


E Extraction Algorithm works up to ~100 kV/m

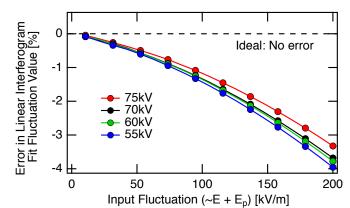
Fit interferogram data via fast matrix inversion with weights

$$\mathbf{c} = \mathbf{\beta} \mathbf{\alpha}^{-1} \quad \mathbf{\beta}_k = \sum_{i} \frac{1}{\sigma_i^2} y_i f_k(x_i) \quad \mathbf{\alpha}_{lk} = \sum_{i} \frac{1}{\sigma_i^2} f_l(x_i) f_k(x_i)$$

- Several assumed constants in fitting algorithm:
 - V_{beam} (beam voltage): unknown, can be characterized, high voltage beam diagnostic suggests $\Delta_{V_{beam}} \sim 200 \text{ Vrms}$
 - Stark component relative intensity: weak dependence on n_e (Marchuk *et al.*, 2010)
 - Component spectral width, w: beam divergence, source temperature, geometric broadening → Needs to be characterized via beam-into-gas studies
- Fit algorithm linear with \lesssim 1% error out to $\tilde{E}+E_p=$ 100 kV/m over range of beam energies





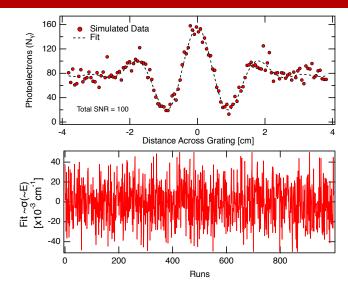


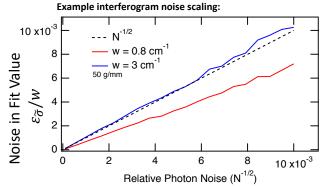


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Noise in Fitted $\tilde{\mathbf{E}}$ is Proportional to Photon Noise

- Algorithm noise evaluation: Scaling of $\varepsilon_{\tilde{\sigma}}/w$ vs relative photon noise and absolute uncertainty of $\tilde{\sigma}$ [cm⁻¹] (\tilde{E} [kV/m])
- Measured total beam emission spectrum SNR~100 at 500 kHz using SHS prototype at D3D
- Monte-Carlo studies evaluated E
 sensitivity with
 photon/amplifier noise, spectrometer parameters, Stark
 spectrum model
 - 1000 interferograms generated with Poisson noise applied given SNR, no perturbation ($\tilde{\mathbf{E}} = 0$)
 - $\varepsilon_{\tilde{\sigma}}(\tilde{\mathbf{E}})$, standard deviation of fitted spectral fluctuation value
 - w, standard deviation of width of individual π components
- Uncertainty in fitted spectral fluctuation $(\tilde{\mathbf{E}})$ scales linearly with relative photon noise



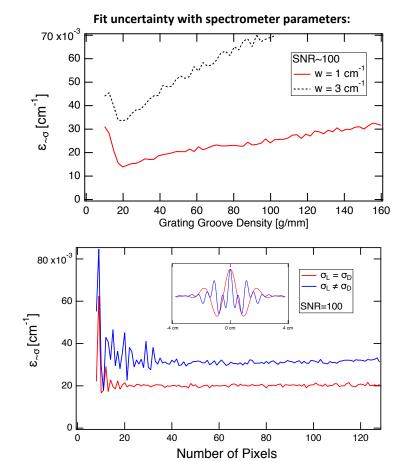




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Monte-Carlo Studies Used to Determine Spectrometer Parameters

- Lower fluctuating wavenumber uncertainty $(\varepsilon_{\widetilde{\sigma}})$ is better
- Optimal groove density (i.e. SHS resolution) that maximizes sensitivity to E is ~25 g/mm
- Spectral width of individual Stark components reduces sensitivity
- Number of detector pixels required depends on the complexity of the interferogram → controllable by Littrow wavenumber
 - ~64 pixels adequate to fully resolve fluctuations in complex interferogram
 - Sub sampling with reduced pixel number must be matched to Littrow wavenumber configuration
 - Likely want more pixels than 64 so facilitate distortion correction of 2D interferogram

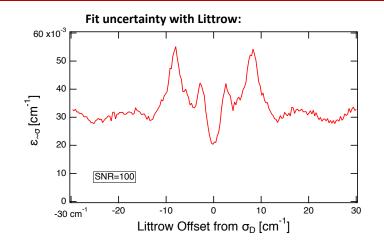


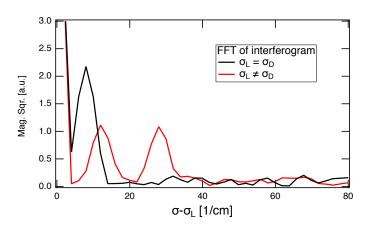




Littrow wavenumber Placement Can Maximize SNR

- Stark $\pm \pi$ -components are symmetric about Doppler shift wavenumber (σ_D)
- Placing $\sigma_L = \sigma_D$ gives lowest $\varepsilon_{\tilde{\sigma}}$
- Placing $\sigma_L = \sigma_D$ effectively doubles the SNR in the spectral domain (see FFT of interferogram)
- Maintaining the interferometer at $\sigma_L = \sigma_D$ could be challenging
 - Mechanical vibrations and thermal swings must be counteracted
 - Requires *in-situ* calibration/monitoring of σ_L
- Wavefront errors maximized here, 2D detector allows for phase correction data processing



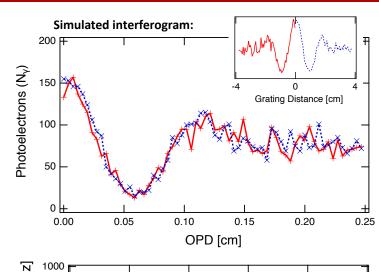


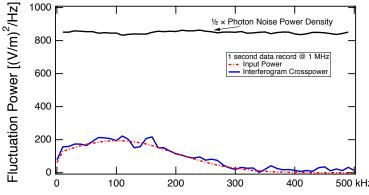


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SHS has Built in Correlation Detection Capabilities

- Symmetry of SHS interferogram allows for ~10x reduction of photon noise floor via cross correlation of the two sides of the interferogram
 - SHS optical path different (OPD) in terms of $\delta \sigma = |\sigma \sigma_L|$
 - Splitting the interferogram at zero-path-length-difference point provides two measurements of same quantity $(\tilde{\mathbf{E}}) \rightarrow$ cross correlation suppresses incoherent photon noise present in both measurements
 - Can be done with single spatial channel
- Long time records required to pull ~E from background
 - Example plot: 10 kHz BW, 1 second data record with 1 MHz sampling
- Combination of techniques allows for fluctuations of order 1 kV/m to be measured from signal with ~1% photon noise
 - D3D $\tilde{\mathbf{E}}$ estimated to be ~3 kV/m in core region, larger at edge







Geometric Doppler Shift Correction via Offset Aperture in SHS

- Similar Doppler shift correction utilized in planetary wind Fabry-Perot spectroscopy techniques*
- At spectrometer, window image rotated 90° so that $\Delta \sigma_D$ is perpendicular to dispersion plane ($\Delta \sigma_D(\alpha)$, where α is angle off dispersion plane)
- SHS interferogram equation phase can be rederived to include small aperture offset angle α_0 , $\alpha = \alpha_0 \pm \phi$ (ϕ is spectrometer field of view):

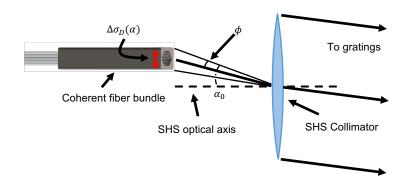
$$\sigma d \cos \alpha \left(\sin \theta_{in} + \sin \theta_{out} \right) = m$$

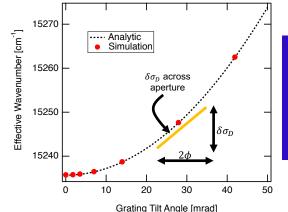
$$\Phi(x) = 2\pi \left(4x \tan \theta_L \left[-\delta \sigma_D + \frac{\sigma}{2} (\beta^2 + \phi^2 + 2\phi \alpha_0 + \alpha_0^2) \right] \right)$$

For Doppler compensation: $-\delta\sigma_D + \sigma\phi\alpha_0 = 0$

• For $\delta \lambda_D \sim 0.4$ nm, $\phi_{max} = \sqrt{8/R} \sim 16$ mrad $\rightarrow \sim 30$ mrad

Doppler compensation concepts in SHS:





Ray trace simulation:

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 α_0 = 26 mrad $\delta \sigma_D$ = 9 cm⁻¹ ϕ = 7 mrad



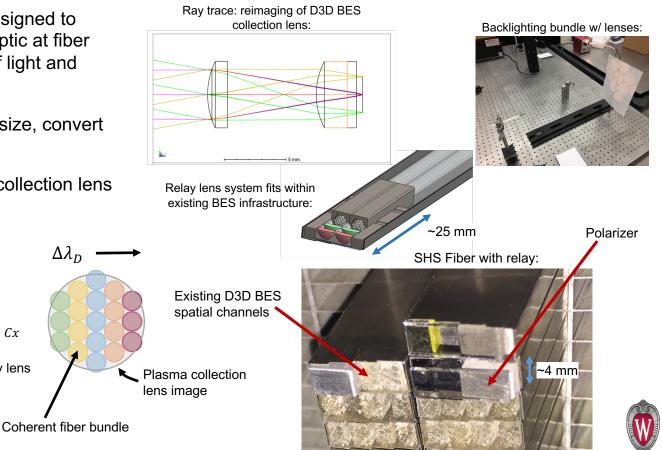
Geometric Broadening Compensation: Collection Lens Relay System to SHS

- Small relay lens system designed to place image of collection optic at fiber bundle with minimal loss of light and plasma spatial resolution
- Lenses create ~3mm spot size, convert from f/3 to f/2
- New fiber bundle run cuts collection lens into 5 regions

D3D plasma collection lens

 $\lambda_0 - \lambda_x = Cx$

Relay lens

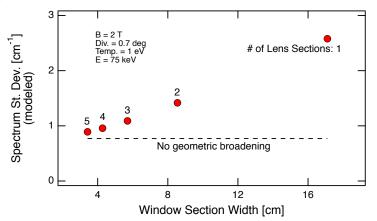


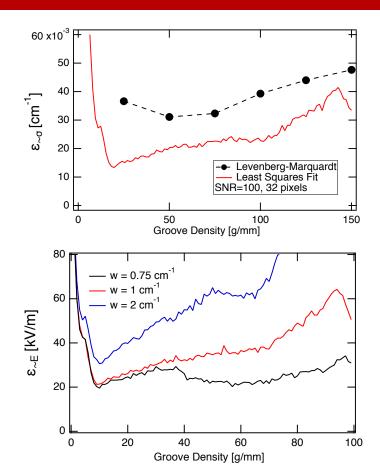


 v_{beam}

Algorithm in Place to Extract **E**

- Least squares fit algorithm to Stark SHS interferogram is fast, robust (small-to-zero failure)
- Least squares algorithm performs similarly to Levenberg-Marquardt nonlinear fit algorithm
- Overall spectral width, w, has strong effect on $\varepsilon_{\tilde{E}}$
- Stark spectral modeling indicates w can be reduced ~2.5x



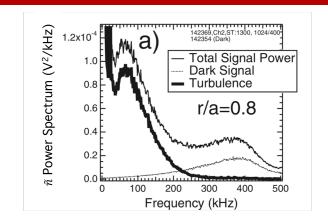


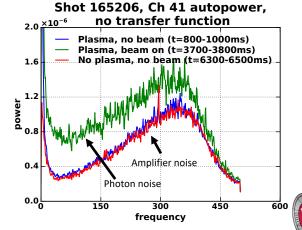




SHS Detector Requires High Internal Gain and Low Additive Noise

- SHS output requires high-speed 2D imaging detector
 - SHS produces ~75mm diameter interferogram image, minified ~36X at detector
 - Detector sampling rate \gtrsim 400 kHz covers most commonly observed low-k broadband turbulence and low frequency coherent modes (\tilde{n} : GAMs, \tilde{B} : EHO & RMP)
- Spectral resolving beam emission results in ~1% total flux in given bin
 - Flux per spectral bin well below high-performance photodiode amplifiers
- 3rd generation photocathodes and production techniques allow photo-multiplying devices (microchannel plates, hybrid SI-diode tubes) to be comparable to high-QE devices (APDs)
 - Avalanche Photodiode: QE~80%, Gain~250, Excess noise~2.5, Net QE~32%, \$
 - Hybrid Si-diode tube: QE~40%, Gain~10⁵, Excess noise~1, Net QE~40%, \$\$\$\$
 - GaAs photocathode & microchannel plate: QE~35%, Gain~10⁴, Excess noise~1.1, Net QE~32%, \$







G. Mckee, et al., Rev. Sci. Inst., (2010)

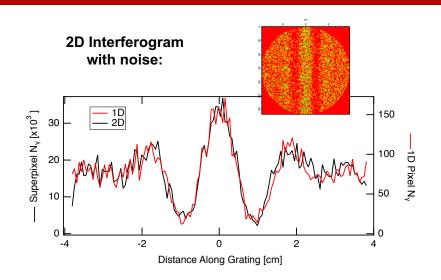
Intensified CMOS to be Detector System For Diagnostic Validation

- Easier coupling to SHS output image (no fiber bundle coupling or reimaging losses)
- Equivalent QE to APD with more gain
- Excess noise in image intensifiers driven by MCP open-area ratio (ϑ) and noise in first stage gain (g_v)

$$\varepsilon_{out}^2 = F \varepsilon_{in}^2, \qquad F \approx \frac{1}{\vartheta} \left[1 + \frac{1}{g_p} \right]$$

- g_p typically 5-10 due to MCP entrance coating
- 98% collection efficiency MCP and coating design push excess noise (F) to ~1.1
- Modest gain needed to become photon noise dominated when binning over *M* pixels

$$\frac{\varepsilon_{S}^{2}}{S^{2}} = \frac{1}{N_{T}} \left[1 + \frac{1}{g_{p} - 1} \right] + \frac{1}{M(g_{p} - 1)} + \frac{M\varepsilon_{R}^{2}}{N_{T}^{2}\bar{G}^{2}}$$



Fit wavenumber uncertainty ($\varepsilon_{\widetilde{\sigma}}$) with 2D detector noise:

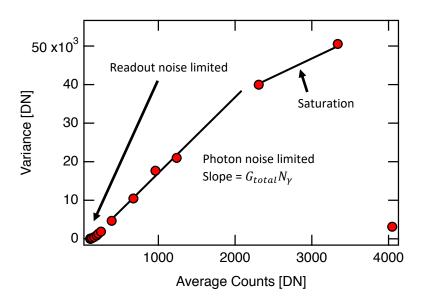
Interferogram	Gain	Excess Noise (F)	Readout Noise ($arepsilon_R$)	$arepsilon_{\widetilde{\sigma}} [cm^{-1}]$
1D	1	1	0	0.0187
2D	250	1	27 phe-	0.0199
2D	250	1.2	27 phe-	0.0256



4.G. Burke, APS DPP 2018 *1% photon noise, M=128

Experience with Intensified CMOS Indicates Photon Noise Limited Performance

Phantom v310 and Proxitronix UV intensifier:



 G_{total} includes camera gain, sensor QE, total intensifier gain, coupling optic efficiency,

SHS Detector Parameters: Phantom v2012 & Photonis GaAs Image Intensifier



Parameter	Units	Value
Max Spectral Bins	Pixels	128
Sample Rate	kHz	670 (128x80 pixels) 430 (128x128 pixels)
MCP Open-Area-Ratio	%	>95
MCP Saturation Current	μΑ	18-40
Photocathode QE	%	35
Phosphor 90-10% Decay Time	ns	~300
Max Gain	W/W	5000
Readout Noise	photoelectron	27
Dynamic Range	dB	57
Pixel Size	um	28





Summary

- Analysis technique based on least-squares linear regression algorithm extracts E
 from ~20 Gb/shot data set
 - Algorithm $\tilde{\mathbf{E}}$ fit value scales linearly with relative photon noise
 - Monte Carlo studies inform SHS design and maximize sensitivity to $\tilde{\mathbf{E}}$
 - Inherent correlational detection technique and \sim 1 second time records give sensitivity to $\tilde{\mathbf{E}}$ on the order of 2 kV/m
- Intensified CMOS detector designed/being built for diagnostic technique validation
 - Combines Phantom v2012 with Photonis high collection efficiency MCP GaAs image intensifier
 - Detector designed for high speed (~500 kHz), high internal gain (10⁴) with low excess noise (F~1.1)
- Final testing at UW, deployment to D3D in mid-2019





Layout Slide (Include for Posters)

Panel size: 8' x 4' 12:1 scale Title Strip Introduction Predictive Modeling **Detector Development** Diag. Requirements Understanding \tilde{E}/\vec{E}_{MSE} in Linearized Turbulence in Tokamaks is a Fundamental **Fusion Grade** Interferogram Challenge for Fusion Derivation Plasmas is ~10-3 Energy Motional Stark Effect Field Used as How SHS works Carrier Signal for \tilde{E} and \tilde{B}





Summary: Validation and Field Tests of Spatial Heterodyne Spectrometer for $ilde{E}$ Measurement

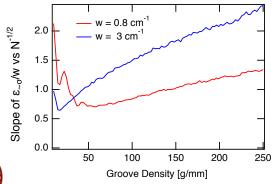
- First field tests of prototype SHS for $\Delta \tilde{\lambda}_{\pi} \propto \tilde{E}$ measurement completed
 - Spectrometer validated at $\lambda \delta \approx 0.16$ nm and $U \approx 0.03$ cm²sr
 - Signal level gives ~1% photon statistics, adequate for turbulence measurements (room for improvement with custom gratings & new detector system)
 - Produced BES spectrum with SHS, observed rapid changes in fringe pattern corresponding with beam modulations
- Development for Turbulence Measurements on DIII-D: Construct & Deploy "Phase 2"
 - Fabricate final detector system (either intensified phantom or multianode MCP: ~1 MHz sampling, low readout noise)
 - Address lab vibrations with monolithic low thermal expansion grating-beam splitter mount design, or discuss moving spectrometer
 - Continued development of high speed fringe data analysis algorithms: focus on sensitivity with noise
 - Off-line validation of geometric Doppler broadening compensation technique for SHS
 - Integrating multiple spatial points into single spectrometer

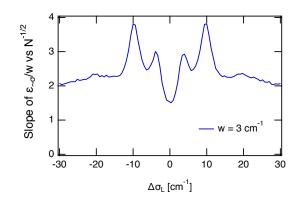


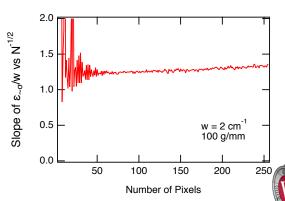


Monte-Carlo Studies of spectrometer Predict \tilde{E} Sensitivity

- Expect uncertainty in LSF spectral fluctuation to scale similarly to gaussian fit location (μ) uncertainty in spectral domain, $\varepsilon_{\mu} \rightarrow \frac{\mathrm{Var}[\varepsilon_{\mu}]}{w^2} = \frac{1}{N_{\nu}}$
- LSF $\varepsilon_{\widetilde{\sigma}}/w$ deviates from expected $N_{\nu}^{-1/2}$ scaling over range of spectrometer parameters
 - Slope $< 1 \rightarrow \varepsilon_{\widetilde{\sigma}}$
- This analysis is ongoing → general trends









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